

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT****Complete if Known**

Application No.	10/561,256
Filing Date	July 25, 2006
First Named Inventor	Takamasa Koshizen
Art Unit	2624
Examiner Name	Eric Rush
Attorney Docket Number	23085-08069

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U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Document No. Number – Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ – Number ⁴ Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	T ⁶
	B1	JP 03-226874 (with English abstract)	10-07-1991	Fujitsu Ltd.	
	B2	JP 2003-150963 A	05-23-2003	Japan Science & Technology Corp. et al.	X
	B3	JP 04-264985 (with English abstract)	09-21-1992	Hamamatsu Photonics K.K.	
	B4	JP 04-175964 (with English abstract)	06-23-1992	Hitachi Ltd.	
	B5	JP 07-065165 A	03-10-1995	IBM Japan Ltd.	X
	B6	JP 10-232938	09-02-1998	Honda Motor Co. Ltd.	X
	B7	WO 2002/039371 A2	05-16-2002	Koninklijke Philips Electronics N.V.	

OTHER REFERENCES – NON-PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T ⁶
	C1	CLIPPINGDALE, S. et al., "Performance Improvement and Database Registration in the FAVRET Face Detection, Tracking and Recognition System," Technical Report of the Institute of Electronics, Information and Communication Engineers, March 8, 2001, Volume 10, No. 701, pp. 111-118, Japan (with English abstract).	
	C2	European Patent Office Communication, European Patent Application No. EP 04777379.1, August 5, 2009, 3 pages.	
	C3	Japanese Office Action, Japanese Patent Application No. 2006-517819, February 17, 2010, 10 pages.	X
	C4	Japanese Office Action, Japanese Patent Application No. 2006-516619, February 16, 2010, 9 pages.	X

Examiner Signature		Date Considered	
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